

# SPICE Device Model Si1539DL

## **Vishay Siliconix**

## N- and P-Channel 30-V (D-S) MOSFET

### **CHARACTERISTICS**

- N- and P-Channel Vertical DMOS
- Macro Model (Subcircuit Model)
- Level 3 MOS

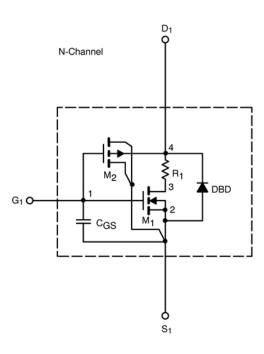
- · Apply for both Linear and Switching Application
- Accurate over the –55 to 125°C Temperature Range
- Model the Gate Charge, Transient, and Diode Reverse Recovery Characteristics

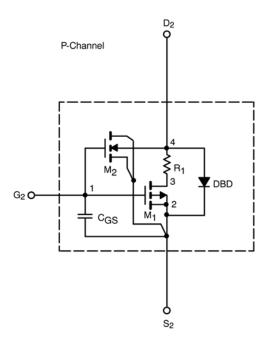
### **DESCRIPTION**

The attached spice model describes the typical electrical characteristics of the n- and p-channel vertical DMOS. The subcircuit model is extracted and optimized over the -55 to  $125\,^{\circ}\mathrm{C}$  temperature ranges under the pulsed 0-V to 5-V gate drive. The saturated output impedance is best fit at the gate bias near the threshold voltage.

A novel gate-to-drain feedback capacitance network is used to model the gate charge characteristics while avoiding convergence difficulties of the switched  $C_{\rm gd}$  model. All model parameter values are optimized to provide a best fit to the measured electrical data and are not intended as an exact physical interpretation of the device.

### SUBCIRCUIT MODEL SCHEMATIC





This document is intended as a SPICE modeling guideline and does not constitute a commercial product data sheet. Designers should refer to the appropriate data sheet of the same number for guaranteed specification limits.

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SPECIFICATIONS (T <sub>J</sub> = 25°C UNLESS OTHERWISE NOTED)					
Parameter	Symbol	Test Condition		Typical	Unit
Static					
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$ , $V_{GS}$ , $I_D = 250 \mu A$	N-Ch	2	V
		$V_{DS} = V, V_{GS}, I_{D} = -250 \mu A$	P-Ch	2.2	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	N-Ch	11	A
		$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	P-Ch	5	
Drain-Source On-State Resistance <sup>a</sup>	r <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 0.59 A	N-Ch	0.41	Ω
		$V_{GS} = -10 \text{ V}, I_D = -0.20 \text{ A}$	P-Ch	0.83	
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 0.40 A	N-Ch	0.57	
		$V_{GS} = -4.5 \text{ V}, I_D = -0.25 \text{ A}$	P-Ch	1.5	
Forward Transconductance <sup>a</sup>	<b>g</b> fs	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 0.59 A	N-Ch	1	S
		$V_{DS} = -15 \text{ V}, I_{D} = -0.42 \text{ A}$	P-Ch	0.57	
Diode Forward Voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>S</sub> = 0.23 A, V <sub>GS</sub> = 0 V	N-Ch	0.67	
		$I_{S} = -0.23 \text{ V}, V_{GS} = 0 \text{ V}$	P-Ch	-0.76	
Dynamic <sup>b</sup>					
Total Gate Charge <sup>b</sup>	$Q_g$		N-Ch	0.96	
		$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	P-Ch	0.83	
Gate-Source Charge <sup>b</sup>	$Q_gs$		0.24	nC	
			P-Ch	0.21	
Gate-Drain Charge <sup>b</sup>	$Q_gd$		N-Ch	0.08	
Gate Diam Gridige	<b>Q</b> g₀		P-Ch	0.17	
Turn-On Delay Time <sup>b</sup>	$t_{d(on)}$		N-Ch	6	
		N. Channel	P-Ch	6	
Rise Time <sup>b</sup>	t <sub>r</sub>	N-Channel $V_{DD}$ =15 V, $R_L$ = 30 $\Omega$	N-Ch	8	
		$I_D\cong 0.5$ A, $V_{GEN}$ = 10 V, $R_G$ = 6 $\Omega$	P-Ch	7	
Turn-Off Delay Time <sup>b</sup>	$t_{d(off)}$	P-Channel $V_{DD} = -15 \text{ V}, R_{I} = 30 \Omega$	N-Ch	11	ns
		$I_D \simeq -0.5 \text{ A}, V_{GEN} = -10 \text{ V}, R_G = 6 \Omega$	P-Ch	7	
Fall Time <sup>b</sup>	t <sub>f</sub>		N-Ch	12	
			P-Ch	8	
Source-Drain Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 0.23 A, di/dt = 100 A/μs	N-Ch	15	
		$I_F = -0.23 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	P-Ch	20	

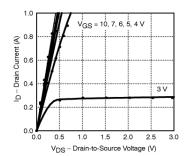
a. Guaranteed by design, not subject to production testing. b. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

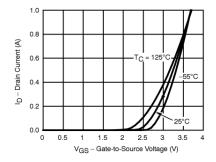


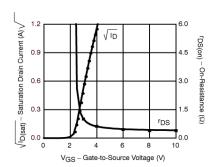
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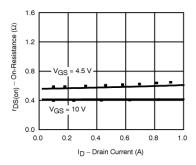
### COMPARISON OF MODEL WITH MEASURED DATA (TJ=25°C UNLESS OTHERWISE NOTED)

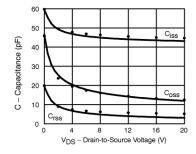
### **N-Channel MOSFET**

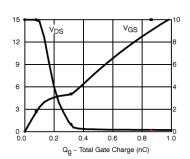












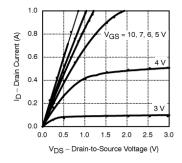
Note: Dots and squares represent measured data.

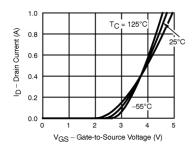
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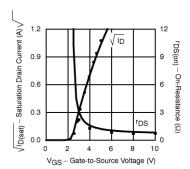
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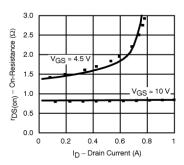
### **P-Channel MOSFET**

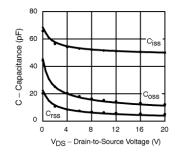


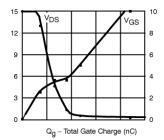












Note: Dots and squares represent measured data



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